

A 5GHz VCO with Series Varactor Bank to Compensate Large K_{vco}

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Abstract

This paper presents the design of a voltage controlled oscillator (VCO) with small VCO gain (K_{vco}) variation. To compensate large K_{vco} variation, a series varactor bank has been added to the conventional LC-tank with parallel capacitor bank array. Implemented in a 0.13 μ m CMOS RF technology, the proposed VCO can be tuned from 4.6GHz to 5.5GHz with the K_{vco} variation of less than 9.6%. While consuming 3.1mA from a 1.2V supply, the VCO has -120dBc/Hz phase noise at 1MHz offset from the carrier.

Keywords: CMOS (Complementary Metal Oxide Semiconductor), VCO (Voltage controlled oscillator), AMOS (Accumulation MOS) varactor, Series varactor bank

1. Introduction

Among The VCO gain (K_{vco}) of conventional structure is variable across the entire tuning range, which increases the phase noise but is useful for widening the tuning range of the VCOs, and this essentially nonlinear characteristic will deteriorate the phase noise performance of VCO and phase locked loop [1,2]. To cover such a wideband frequency range, switching capacitor array is usually used in LC voltage-controlled-oscillator (VCO) to extend the tuning range with low VCO tuning gain (K_{vco}), which avoids degrading the phase noise performance. For low phase noise, it is desirable to have as small a K_{vco} as possible, but small K_{vco} means narrow frequency locking range. To extend the frequency locking range with small K_{vco} , the LC-tank VCO may employ a switchable capacitor bank [3–6]. The oscillation frequency of the LC-tank VCO is given as

$$f_{osc} = \frac{1}{2\pi \sqrt{L(C_v + C_{Cap.bank})}} \quad (1)$$

Where C_v and $C_{Cap.bank}$ are the capacitance of the varactor and switchable capacitor bank, respectively. The oscillation frequency f_{osc} is coarsely controlled by $C_{Cap.bank}$ and finely tuned by C_v , whose value is determined by V_{tune} . The VCO gain, K_{vco} , can be derived as given by Eq. (2)

$$K_{vco} = \frac{\partial f_{osc}}{\partial V_{tune}} = - \frac{1}{4\pi \sqrt{L(C_v + C_{Cap.bank})}^{1.5}} \cdot \frac{\partial C_v}{\partial V_{tune}} \quad (2)$$

From the above equation, it can be easily shown that K_{vco} is a strong function of the capacitance $C_{Cap.bank}$ of the switched capacitor bank. Therefore, the loop characteristics of the PLL employing the LC-tank VCO will change according to the value of $C_{Cap.bank}$, which is a function of the operation frequency of the PLL. Then, the loop characteristics of the PLL cannot be optimized for the whole operation frequency range due to the variation of K_{vco} . This problem becomes more severe when the frequency tuning range is required to be wide. For wide frequency tuning range, the difference between the minimum and maximum values of $C_{Cap.bank}$ would be large, meaning the large variation of K_{vco} . Therefore,

there must be a trade-off between the frequency tuning range and VCO gain variation. This paper proposes a series-varactor, parallel capacitor bank structure which minimizes the VCO gain variation. Section 2 describes AMOS varactor and the proposed VCO circuit. Results of the VCO implemented in a 0.13 μm CMOS technology are given in Section 3. The conclusion follows in Section 4.

2.1 AMOS (Accumulation MOS) Varactor

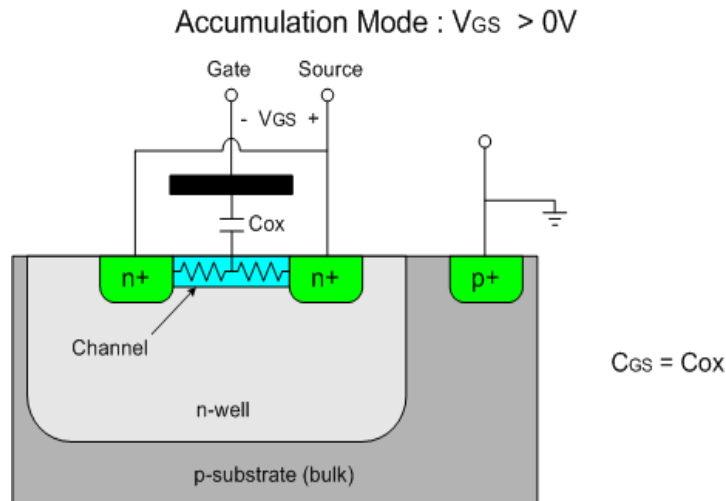


Figure 1. AMOS Varactor Structure and Operation

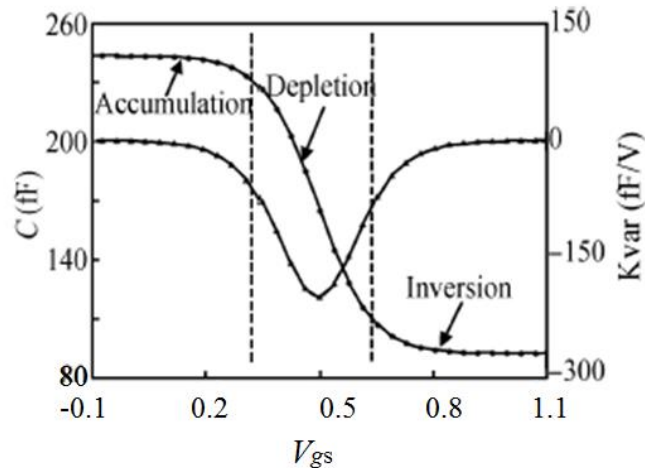


Figure 2. AMOS Varactor C-V Characteristic

The accumulation MOS (AMOS) varactor has been a popular choice for VCO varactor, and has been employed in many VCO circuits.[7-13] The AMOS varactor has three modes of operation: accumulation, depletion, and inversion, and the capacitance of this device depends on the mode of operation. An MOS based varactor with drain, source and bulk (S = D = B) configuration is utilized in the proposed VCO design. The dc tuning voltage (V_{tune}) is applied at the gate of nMOS varactor and variable capacitance is achieved. The required capacitance of nMOS varactor can be achieved using Eq. (3).

$$C_v = C_{ox} \times W \cdot L \cdot n_f \quad (3)$$

Where C_{ox} is the oxidation capacitance, W is the width, L is the length of the active

device and n stands for the number of the fingers [14].

The structure and operation of the AMOS capacitor is shown in Figure 1, and the C-V characteristic is shown in Figure 2. When the gate electrode is biased at the positive end, the AMOS is operated in the accumulation mode, the C_v represents C_{max} . As the gate electrode becomes negative, a depletion region is formed, and the C_v represents C_{min} . The AMOS varactor has a wider tuning range and lower parasitic resistance, and the VCOs adopting the AMOS varactors demonstrate low power dissipation and low phase noise. The C-V characteristic of the AMOS varactor exhibits a good adjusting ratio ($C_{max}=C_{min}$). However, the C-V curve has a highly nonlinear characteristic, which means K_{var} is not constant across the tuning range, and the more the curve departs from linearity, the more it converts low frequency noise into phase noise [10].

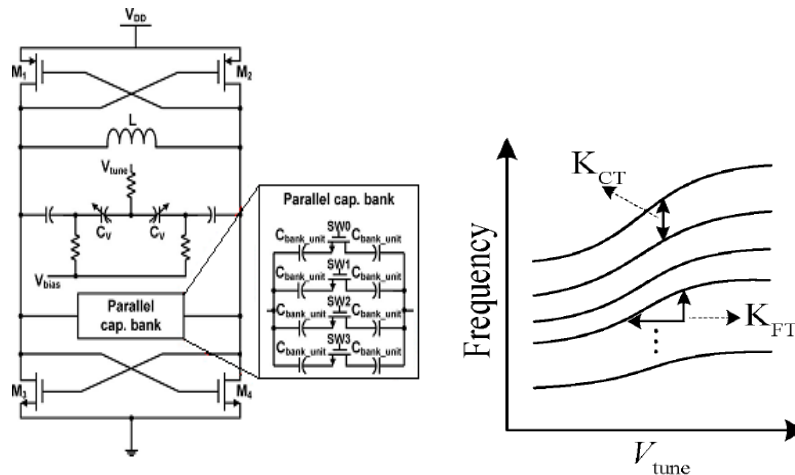


Figure 3. Conventional LC-tank VCO with Parallel Capacitor Bank

2.2. Voltage-controlled Oscillator with Small VCO Gain Variation

The conventional LC-tank VCO shown in Figure 3 employs a switchable capacitor bank that is connected to the varactor in parallel. According to Eq. (2), as $C_{Cap.bank}$ gets larger, $|K_{vco}|$ decreases and thus for higher oscillation frequency, $|K_{vco}|$ becomes larger. To cover a wideband frequency range with low K_{vco} , switching capacitor array is usually adopted, which is shown in Figure 3. Varactor C_v is tuned by the control voltage to change the output frequency continuously, while a binary weighted capacitor array is controlled digitally to shift the output frequency band discretely, where 4-bit is used for example. The typical schematic and tuning characteristic of conventional fully-integrated cross-coupled CMOS LC-VCO is shown in Figure 3. Coarse and fine tuning is realized by setting a proper digital code to the switched capacitor bank and applying an analog voltage to the varactor respectively, and the digital and analog tuning sensitivities are defined as K_{CT} and K_{FT} respectively. To achieve linear tuning characteristic, we should reduce the variation of fine and coarse tuning sensitivity.

Although the switching capacitor topology is useful to extend the output frequency range while maintaining a lower K_{vco} , it has two disadvantages. Firstly, equal capacitor is switched in or out of the bank whenever a lower or higher band is required. Due to the nonlinearity of frequency to capacitance, K_{vco} will change by a factor of 8 when the output frequency doubles by reducing the tank capacitance to a quarter.

If the capacitor bank is connected to the varactor in series as shown in Figure 4, the oscillation frequency is given as

$$f_{osc} = \frac{1}{2\pi} \cdot \sqrt{\frac{C_v + C_{ser.Var}}{L(C_v C_{ser.Var})}} \quad (4)$$

and the VCO gain K_{VCO} is

$$\begin{aligned} K_{VCO} &= \frac{1}{4\pi C_v^2} \cdot \sqrt{\frac{C_v C_{ser.Var}}{L(C_v + C_{ser.Var})}} \cdot \frac{\partial C_v}{\partial V_{tune}} \\ &= -\frac{1}{8\pi^2 C_v^2 L} \cdot \frac{1}{f_{osc}} \cdot \frac{\partial C_v}{\partial V_{tune}} \end{aligned} \quad (5)$$

Therefore, for higher oscillation frequency, K_{VCO} decreases with a series-connected varactor bank while it increases with a parallel-connected capacitor bank. So, if we combine the series-connected varactor bank and parallel-connected capacitor bank as shown in Figure 5, the VCO gain variation can be minimized. To minimize the variations of both the analog tuning gain K_{VCO} and band step for wideband applications, a proposed architecture is shown in Figure 3. The idea is to make both the size of capacitors and varactors changeable. Instead of using one fixed analog varactor and a binary-weighted capacitor array, a number of capacitors and varactors with different values are adopted. At lower frequency band the gain K_{VCO} is low, so a majority of varactor units are connected to the analog control voltage, and other varactor units are connected to the power supply or ground to get minimum fixed capacitance. On the contrary, at higher frequency band only a minority of varactor units are switched in. On the other hand, to obtain equal frequency band step, the fixed capacitors are also made changeable.

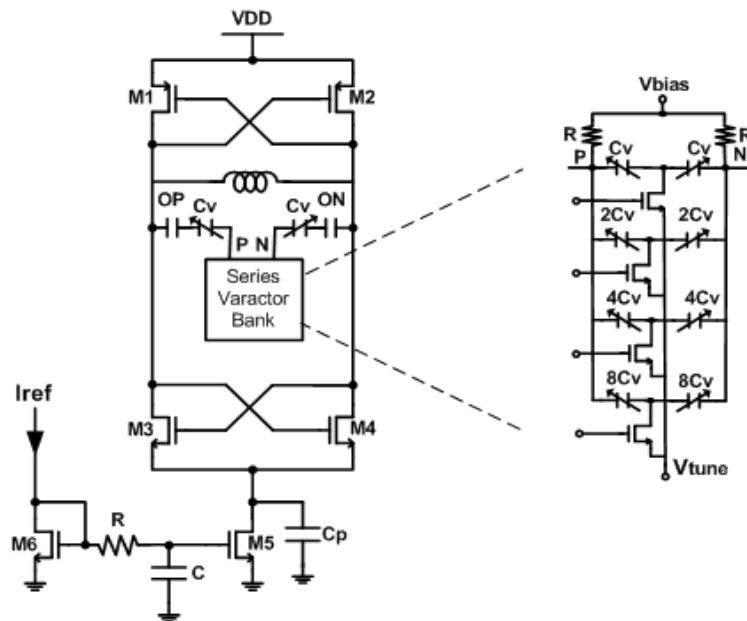


Figure 4. Conventional LC-tank VCO with Series Varactor Bank

The oscillation frequency of the proposed VCO shown in Figure 5 is given as

$$f_{osc} = \frac{1}{2\pi \sqrt{L(C_v \parallel C_{ser.Var} + C_{par.Cap})}} \quad (6)$$

and the VCO gain K_{VCO} is Eq. (7), shown below, where $\alpha = C_{ser.Var}/C_{par.Cap}$. We can find the design parameters such as α and $C_{ser.Var}$ (Series varactor bank) which minimize the

variation of K_{vco} . To obtain right above parameters, $C_{par.Cap}$ (Parallel capacitor bank), V_{tune} are actually fixed in this simulation.

$$K_{vco} = - \frac{(C_{ser.Var} / C_{par.Cap})^2 \cdot C_{ser.Var}}{4\pi \sqrt{L(C_v + (C_{ser.Var} / C_{par.Cap}) \cdot C_{ser.Var})} \{C_v(1 + C_{ser.Var} / C_{par.Cap}) + C_{ser.Var}\}^{1.5}} \cdot \frac{\partial C_v}{\partial V_{tune}} \quad (7)$$

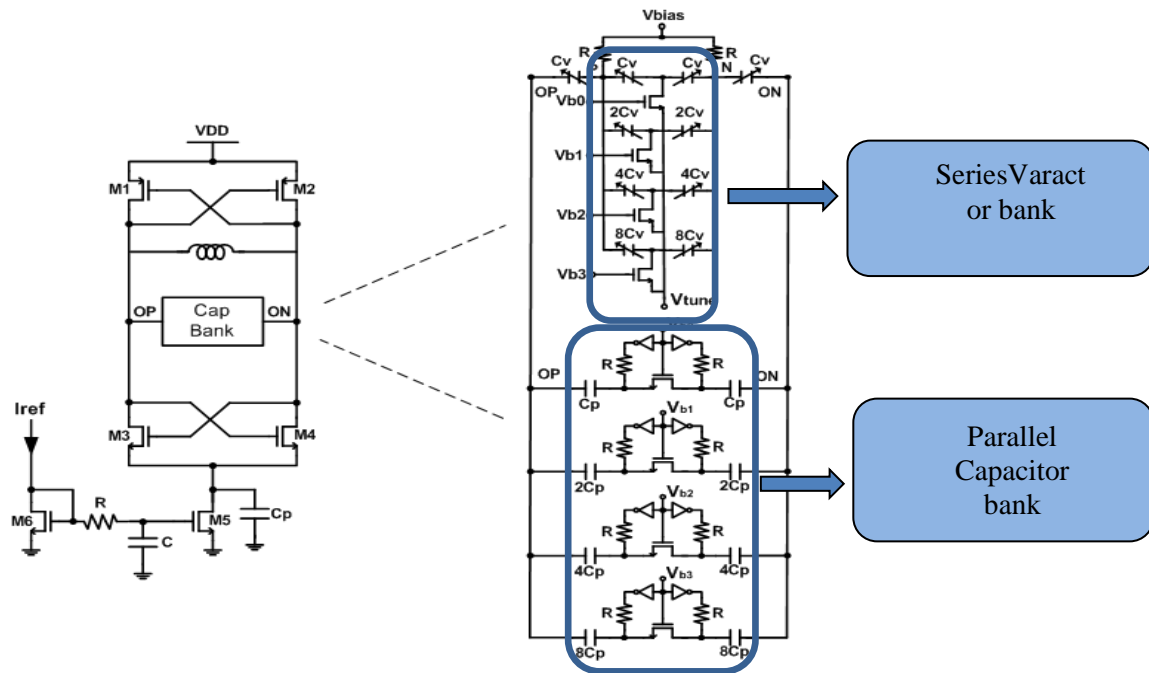


Figure 5. Proposed LC-tank VCO with Series Varactor Bank

3. Measurement Result

The wide band VCO with small K_{vco} variation has been implemented in a $0.13\mu\text{m}$ 1-poly, 6-metal CMOS RF technology. Figure 6 shows the microphotograph of the fabricated chip.

As shown in Figure 6, microphotograph of the proposed VCO occupies less than 0.24mm^2 . The output frequency of the proposed VCO can be tuned from 4.6 GHz to 5.5 GHz as shown in Figure 7. The phase noise of the output is measured to be -120dBc/Hz at 1 MHz offset from the carrier frequency of 5.5 GHz as shown in Figure 8. The VCO gain, K_{vco} , and phase noise of the proposed VCO are measured as a function of the control code of the switchable capacitor bank while the analog varactor control voltage V_{tune} is fixed at 0.6 V and the result is shown in Figure 9. The variation of VCO gain is less than 9.6% while the previously reported LC-tank VCOs show larger than 25.3% variation in the VCO gain as summarized in Table I [15–18]. The VCO consumes 3.1 mA from a 1.2 V supply voltage. To compare the performance of the proposed VCO with that of some prior works, the well known figure-of-merit (FoM) of the VCO defined as Eq. (8) is used.

$$FoM = 10 \log \left(\left(\frac{\omega_0}{\Delta\omega} \right)^2 \cdot \frac{1}{L\{\Delta\omega\}P} \right) \quad (8)$$

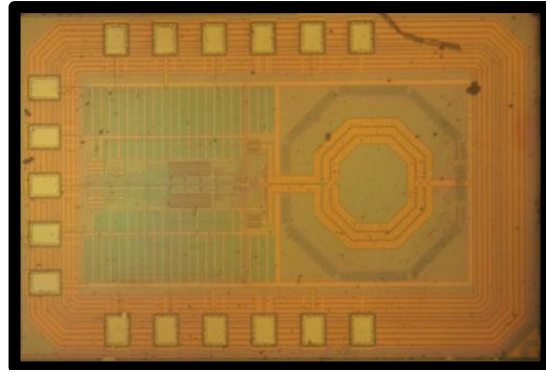


Figure 6. Chip Microphotograph of Proposed VCO

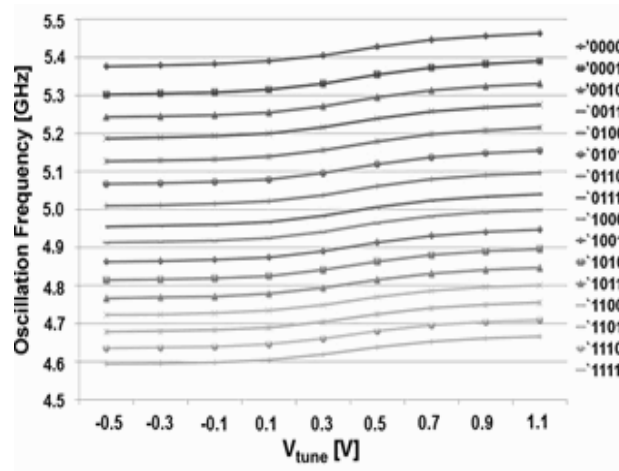


Figure 7. Frequency Tuning Range of the Proposed LC-tank VCO with Series Varactor Bank

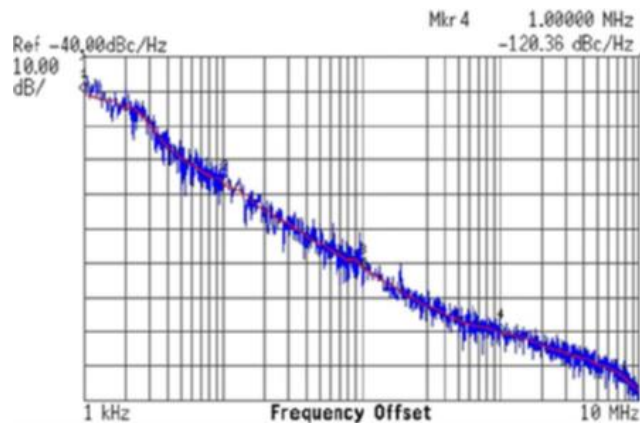


Figure 8. Measured Phase Noise of the Proposed 5.5 GHz VCO

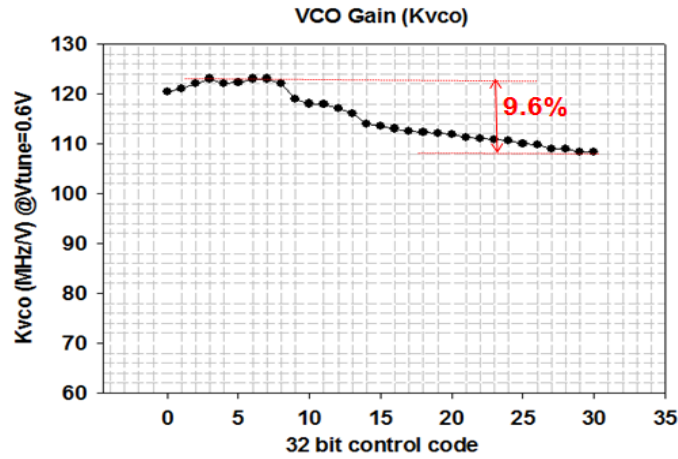


Figure 9. VCO Gain as a Function of Varactor and Cap Bank

Table 1. Comparison of the Performance of Other VCOs

Ref.	fosc [GHz]	Δ KVCO [%]	Tuning Range [%]	Phase Noise [dBc/Hz]	Power [mW]	FoM [dBc]	Tech [μ m]
[15]	6.0	57.5	5.1	-115.2@1M	12.5	179.8	0.13
[16]	1.7	69.5	63.1	-128.0@1M	14.0	179.2	0.18
[17]	1.8	27.2	66.7	-130.0@1M	41.4	175.7	0.18
[18]	2	25.3	52	-124.0@1M	18	176	0.18
This Work	5.5	9.6	18.5	-120@1M	3.72	180	0.13

4. Conclusion

For small variation of VCO gain, series varactor banks and parallel capacitor banks are used together in a wide band LC-tank voltage-controlled oscillator (VCO). Implemented in a 0.13 μ m CMOSRF technology, the proposed VCO shows less than 9.6% variation in the VCO gain while the frequency tuning range is from 4.6 GHz to 5.5 GHz. The VCO consumes 3.1mA from a 1.2V supply and the phase noise is 120dBc/Hz at 1 MHz offset from the carrier.

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